

SIGC156T120R2CQ

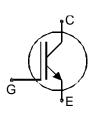
IGBT Chip in Fieldstop-technology

FEATURES:

- 1200V Fieldstop technology 120µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- integrated gate resistor

This chip is used for:

- IGBT Modules
- Applications:SMPS, resonant applications



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC156T120R2CQ	1200V	100A	12.59 X 12.59 mm ²	sawn on foil	SP0000-83655

MECHANICAL PARAMETER:

Raster size	12.59 X 12.59	mm ²				
Emitter pad size	8 x (3.98 x 2.38)					
Gate pad size	1.46 x 0.8					
Area total / active	158.5 / 132.6					
Thickness	120	μm				
Wafer size	150	mm				
Flat position	90	grd				
Max.possible chips per wafer	82 pcs					
Passivation frontside	Photoimide	Photoimide				
Emitter metallization	3200 nm Al Si Cu					
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding					
Die bond	electrically conductive glue or solder					
Wire bond	Al, <500µm					
Reject Ink Dot Size	arnothing 0.65mm ; max 1.2mm					
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C					

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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, Tj=25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t_p limited by T_{jmax}	I _{cpuls}	300	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T _j , T _{stg}	-40 +150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
	Cymbol	Conditions	Min.	typ.	max.	•••••
Collector-emitter breakdown voltage	V _{(BR)CES}	V _{GE} =0V,I _C =5mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =100A		2.1		V
Gate-emitter threshold voltage	V _{GE(th)}	$I_C=4mA$, $V_{GE}=V_{CE}$		5.5		
Zero gate voltage collector current	I _{CES}	V_{CE} =1200V , V_{GE} =0V			12	μA
Gate-emitter leakage current	I _{GES}	$V_{CE}=0V$, $V_{GE}=20V$			600	nA
Integrated gate resistor	R _{Gint}			5	7	Ω

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol Conditions	Value			Unit	
Falameter	Symbol	Conditions	min.	typ.	max.	Omt
Input capacitance	Ciss	V _{CE} =25V,		7850		pF
Output capacitance	Coss	$V_{GE}=0V$,		650		
Reverse transfer capacitance	Crss	f=1MHz		275		

SWITCHING CHARACTERISTICS (tested at component), Inductive Load

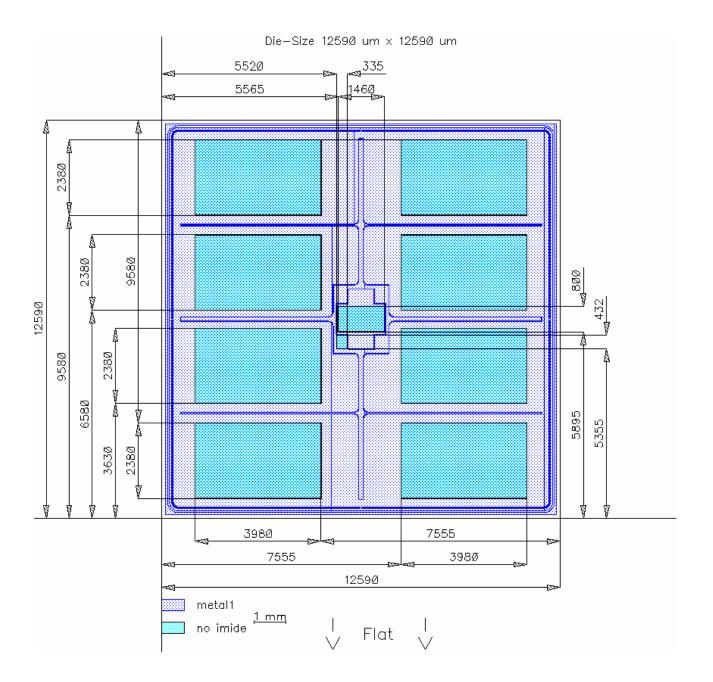
Parameter	Symbol	Conditions ¹⁾	Value			Unit
	Oymbol	Conditions	min.	typ.	max.	onne
Turn-on delay time	t _{d(on)}	<i>T</i> _j =125°C		234		ns
Rise time	<i>t</i> r	$V_{\rm CC} = 600 V$,		40		
Turn-off delay time	$t_{d(off)}$	V _{GE} =-15/15V,		367		
Fall time	t _f	$R_{\rm Gext}$ = 5.6 Ω		84		

¹⁾ values also influenced by parasitic L- and C- in measurement and package.

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CHIP DRAWING:



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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the	
device data sheet	

DESCRIPTION:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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